FDMS3D5N08LC

MOSFET, N-Channel Shielded Gate, POWERTRENCH®

80 V, 136 A, 3.5 mΩ

General Description

This N−Channel MV MOSFET is produced using ON Semiconductor’s advanced POWERTRENCH® process that incorporates Shielded Gate technology. This process has been optimized to minimise on−state resistance and yet maintain superior switching performance with best in class soft body diode.

Features

- Shielded Gate MOSFET Technology
- Max $r_{DS(on)} = 3.5\ m\Omega$ at $V_{GS} = 10\ V$, $I_D = 45\ A$
- Max $r_{DS(on)} = 5.1\ m\Omega$ at $V_{GS} = 4.5\ V$, $I_D = 36\ A$
- 50% Lower Qrr than Other MOSFET Suppliers
- Lowers Switching Noise/EMI
- MSL1 Robust Package Design
- 100% UIL Tested
- RoHS Compliant

Typical Applications

- Primary DC−DC MOSFET
- Synchronous Rectifier in DC−DC and AC−DC
- Motor Drive
- Solar

MOSFET MAXIMUM RATINGS (T_A = 25°C unless otherwise noted)

Symbol	Parameter	Ratings	Unit
V_{DS}	Drain to Source Voltage	80	V
V_{GS}	Gate to Source Voltage	±20	V
I_D	Drain Current − Continuous T_C = 25°C (Note 5)	136	A
	− Continuous T_C = 100°C (Note 5)	86	
	− Continuous T_A = 25°C (Note 1a)	19	
	− Pulsed (Note 4)	745	
E_{AS}	Single Pulse Avalanche Energy	486	mJ
P_D	Power dissipation T_C = 25°C	125	W
	Power dissipation T_A = 25°C (Note 1a)	2.5	
$T_{J,}$ T_{STG}	Operating and Storage Junction Temperature Range	−55 to +150	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

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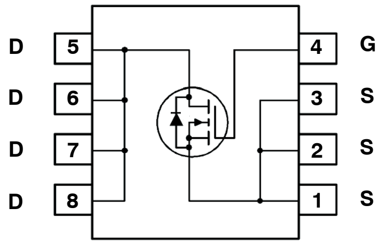
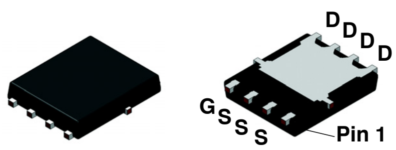
ELECTRICAL CONNECTION



N-Channel MOSFET



Top

Bottom

Power 56
(PQFN8 5x6)
CASE 483AE

MARKING DIAGRAM

$Y&Z&3&K
FDMS
3D5N08LC
○

$Y = ON Semiconductor Logo
&Z = Assembly Plant Code
&3 = Numeric Date Code
&K = Lot Code
FDMS3D5N08LC = Specific Device Code

ORDERING INFORMATION

See detailed ordering and shipping information on page 2 of this data sheet.

October, 2018 − Rev. 0

Publication Order Number:
FDMS3D5N08LC/D

THERMAL CHARACTERISTICS

Symbol	Parameter	Ratings	Unit
$R_{\theta JC}$	Thermal Resistance, Junction to Case	1.0	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient (Note 1a)	50	

PACKAGE MARKING AND ORDERING INFORMATION

Device Marking	Device	Package	Shipping†
FDMS3D5N08LC	FDMS3D5N08LC	PQFN8 5×6 (Pb−Free/Halogen Free)	3000 Units/ Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise noted)

Symbol	Parameter	Test Condition	Min	Typ	Max	Unit
OFF CHARACTERISTICS						
BV_{DSS}	Drain to Source Breakdown Voltage	I_D = 250 μA, V_{GS} = 0 V	80			V
$\frac{\Delta BV_{DSS}}{\Delta T_J}$	Breakdown Voltage Temperature Coefficient	I_D = 250 μA, referenced to 25°C		69		mV/°C
I_{DSS}	Zero Gate Voltage Drain Current	V_{DS} = 64 V, V_{GS} = 0 V			1	μA
I_{GSS}	Gate−to−Source Leakage Current	V_{GS} = ±20 V, V_{DS} = 0 V			±100	nA
ON CHARACTERISTICS						
$V_{GS(th)}$	Gate to Source Threshold Voltage	V_{GS} = V_{DS}, I_D = 250 μA	1.0	1.4	2.5	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate to Source Threshold Voltage Temperature Coefficient	I_D = 250 μA, referenced to 25°C		−5.2		mV/°C
$r_{DS(on)}$	Static Drain to Source On Resistance	V_{GS} = 10 V, I_D = 45 A		2.8	3.5	mΩ
		V_{GS} = 4.5 V, I_D = 36 A		4.0	5.1	
		V_{GS} = 10 V, I_D = 45 A, T_J = 125°C		4.8	6.0	
g_{FS}	Forward Transconductance	V_{DS} = 5 V, I_D = 45 A		300		S
DYNAMIC CHARACTERISTICS						
C_{iss}	Input Capacitance	V_{DS} = 40 V, V_{GS} = 0 V, f = 1MHz		4375	6125	pF
C_{oss}	Output Capacitance			1025	1435	
C_{rss}	Reverse Transfer Capacitance			39	60	
R_g	Gate Resistance		0.1	1.4	3	Ω
SWITCHING CHARACTERISTICS						
$t_{d(on)}$	Turn – On Delay Time	V_{DD} = 40 V, I_D = 45 A, V_{GS} = 10 V, R_{GEN} = 6 Ω		12	22	ns
t_r	Rise Time			20	36	
$t_{D(off)}$	Turn – Off Delay Time			70	112	
t_f	Fall Time			22	35	
Q_g	Total Gate Charge	V_{GS} = 0V to 10 V V_{DD} = 40 V, i_D = 45 A		59	82	nC
Q_g	Total Gate Charge	V_{GS} = 0V to 4.5 V		28	39	
Q_{gs}	Gate to Source Charge			10		
Q_{gd}	Gate to Drain “Miller” Charge			7		
Q_{oss}	Output Charge	V_{DD} = 40 V, V_{GS} = 0 V		56		nC
Q_{sync}	Total Gate Charge Sync.	V_{DS} = 0 V, I_D = 45 A		55		

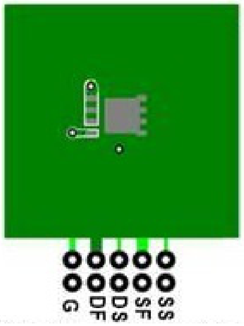
ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise noted) (continued)

Symbol	Parameter	Test Condition	Min	Typ	Max	Unit
DRAIN–SOURCE DIODE CHARACTERISTICS						
V_{SD}	Source to Drain Diode Forward Voltage	V_{GS} = 0 V, I_S = 2.1 A (Note 2)		0.7	1.2	V
		V_{GS} = 0 V, I_S = 45 A (Note 2)		0.8	1.3	
t_{rr}	Reverse Recovery Time	I_F = 22 A, di/dt = 300 A/μs		25	39	ns
Q_{rr}	Reverse Recovery Charge			86	137	nC
t_{rr}	Reverse Recovery Time	I_F = 22 A, di/dt = 1000 A/μs		20	32	ns
Q_{rr}	Reverse Recovery Charge			186	297	nC

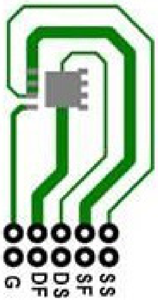
Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

NOTES:

1. $R_{\theta JA}$ is determined with the device mounted on a 1 in^2 pad 2 oz copper pad on a 1.5 × 1.5 in. board of FR−4 material. $R_{\theta CA}$ is determined by the user's board design.



a) 50°C/W when mounted on a 1 in^2 pad of 2 oz copper.



b) 125°C/W when mounted on a minimum pad of 2 oz copper.

2. Pulse Test: Pulse Width < 300 μs, Duty cycle < 2.0%.
3. E_{AS} of 486 mJ is based on starting T_J = 25°C; N−ch: L = 3 mH, I_{AS} = 18 A, V_{DD} = 80 V, V_{GS} = 10 V. 100% tested at L = 0.1 mH, I_{AS} = 57 A.
4. Pulsed I_D please refer to Figure 11 SOA graph for more details.
5. Computed continuous current limited to Max Junction Temperature only, actual continuous current will be limited by thermal & electro−mechanical application board design.

TYPICAL CHARACTERISTICS T_J = 25°C unless otherwise noted

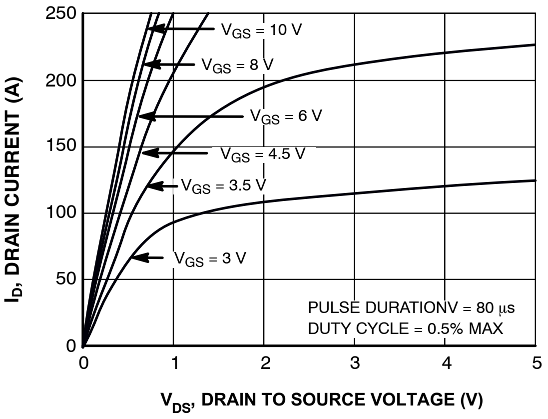


Figure 1. On Region Characteristics

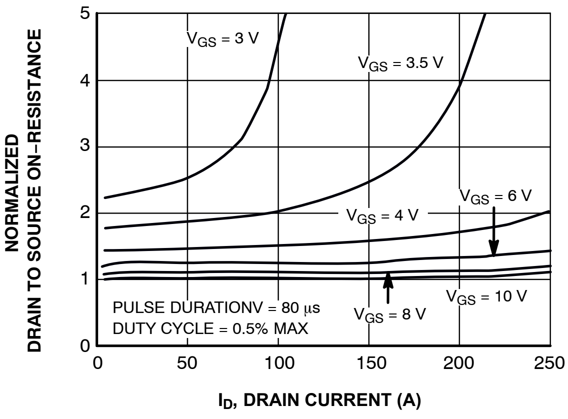


Figure 2. Normalized On−Resistance vs. Drain Current and Gate Voltage

TYPICAL CHARACTERISTICS T_J = 25°C unless otherwise noted (continued)

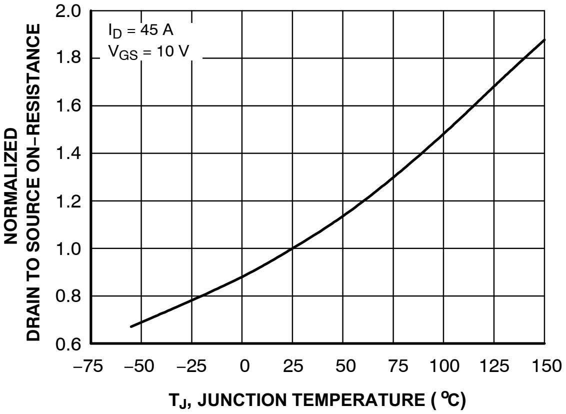


Figure 3. Normalized On Resistance vs. Junction Temperature

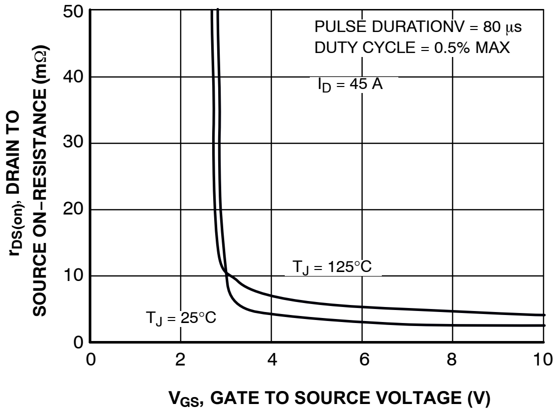


Figure 4. On−Resistance vs. Gate to Source Voltage

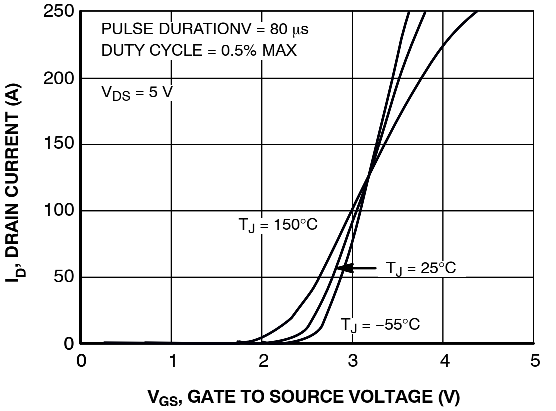


Figure 5. Transfer Characteristics

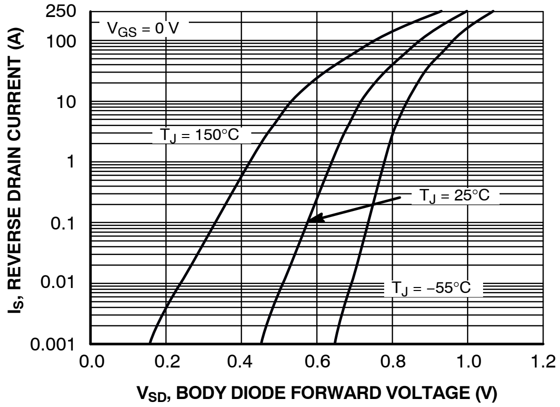


Figure 6. Source to Drain Diode Forward Voltage vs. Source Current

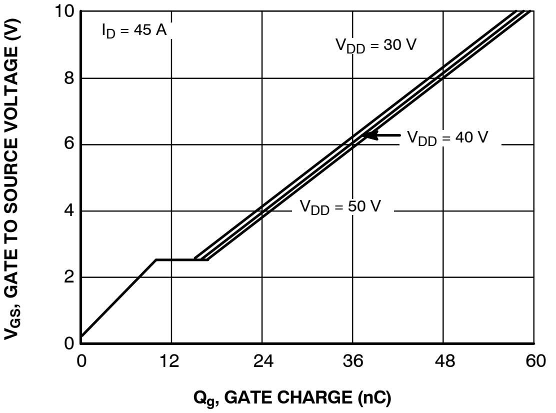


Figure 7. Gate Charge Characteristics

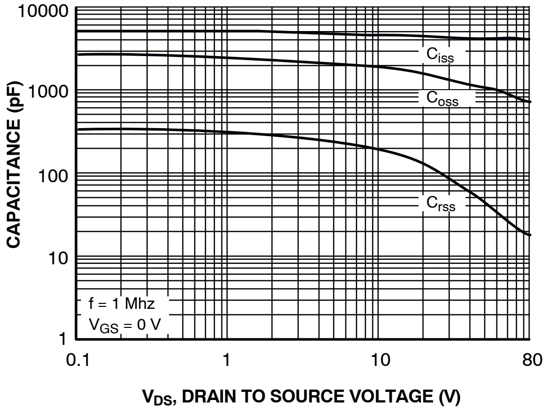


Figure 8. Capacitance vs. Drain to Source Voltage

TYPICAL CHARACTERISTICS T_J = 25°C unless otherwise noted (continued)

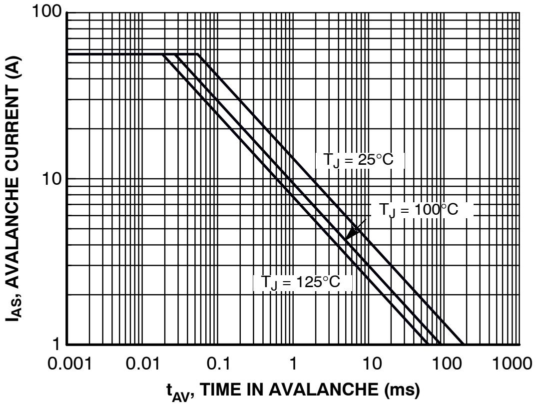


Figure 9. Unclamped Inductive Switching Capability

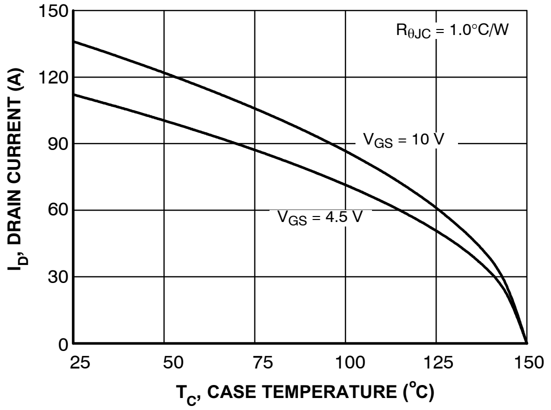


Figure 10. Maximum Continous Drain Current vs. Case Temperature

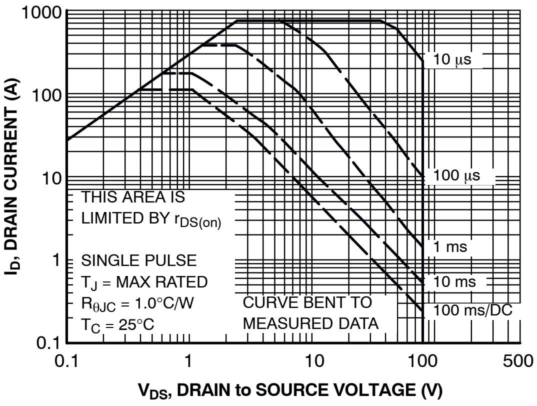


Figure 11. Unclamped Inductive Switching Capability

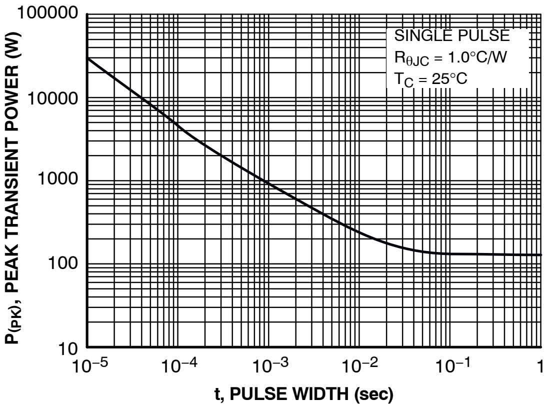


Figure 12. Maximum Continuous Drain Current vs. Case Temperature

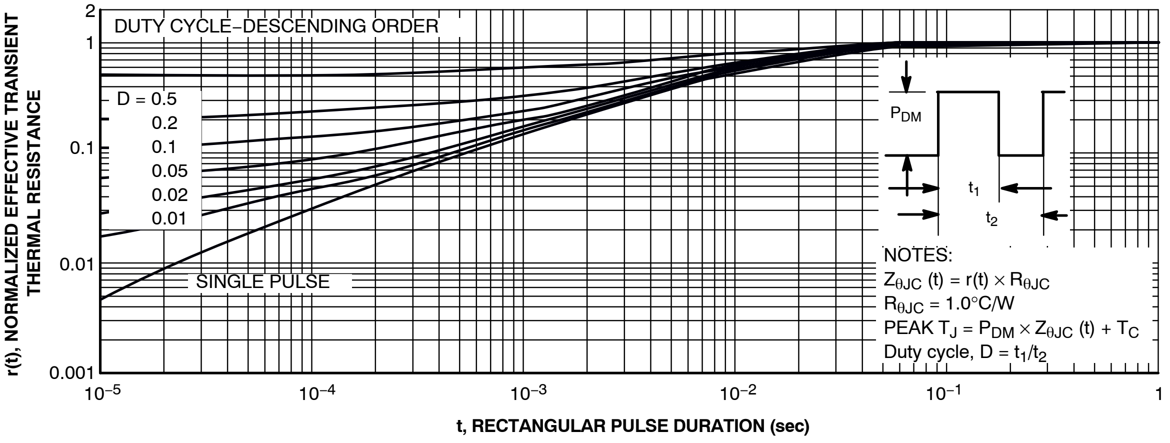
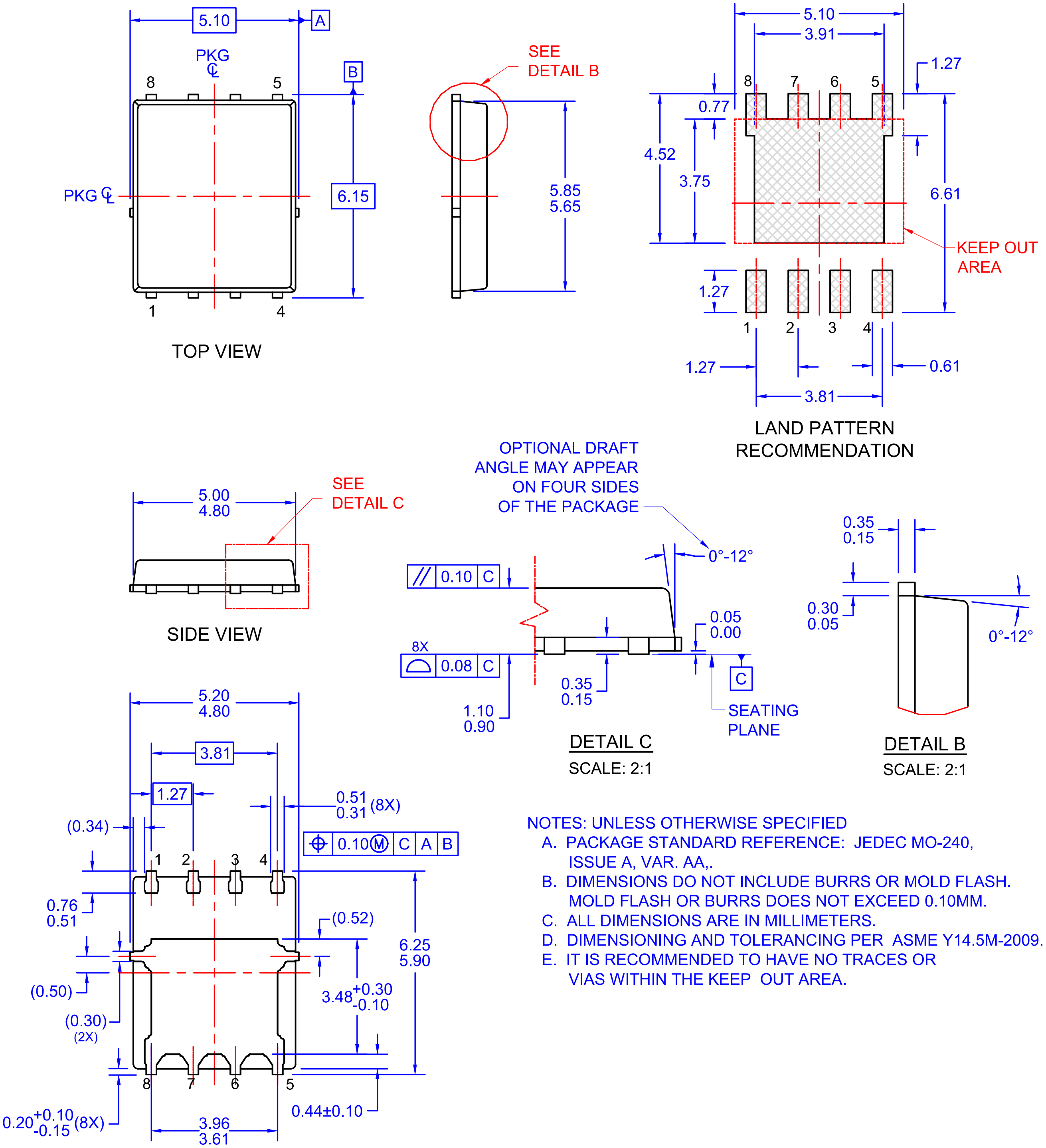


Figure 13. Junction−to−Case Transient Thermal Response Curve

PACKAGE DIMENSIONS

PQFN8 5X6, 1.27P
CASE 483AE
ISSUE A



NOTES: UNLESS OTHERWISE SPECIFIED
- A. PACKAGE STANDARD REFERENCE: JEDEC MO-240, ISSUE A, VAR. AA,.
- B. DIMENSIONS DO NOT INCLUDE BURRS OR MOLD FLASH. MOLD FLASH OR BURRS DOES NOT EXCEED 0.10MM.
- C. ALL DIMENSIONS ARE IN MILLIMETERS.
- D. DIMENSIONING AND TOLERANCING PER ASME Y14.5M-2009.
- E. IT IS RECOMMENDED TO HAVE NO TRACES OR VIAS WITHIN THE KEEP OUT AREA.

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